

EMC TEST REPORT

Report No. : ACS-E20063

Applicant : TPV Electronics (FuJian) Co., Ltd.
Rongqiao Economic and Technological Development
Zone, Fuqing City, Fujian Province, P.R. China

Product : LCD Monitor

Model No. : **24G2****(* = 0-9, A-Z, a-z, +, -, /, \ or blank)

Brand : AOC

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TABLE OF CONTENTS

Description	Page
Test Report Verification	5
1. SUMMARY OF STANDARDS AND RESULTS	6
1.1. Description of Standards and Results	6
2. GENERAL INFORMATION	7
2.1. Description of Device (EUT).....	7
2.2. Tested Supporting System Details.....	8
2.3. Block Diagram of connection between EUT and simulators	9
2.4. Test Facility	10
2.5. Measurement Uncertainty (95% confidence levels, k=2).....	11
3. CONDUCTED EMISSION AT MAINS TERMINALS TEST	12
3.1. Test Equipments	12
3.2. Block Diagram of Test Setup.....	12
3.3. Test Standard	12
3.4. Power Line Conducted Emission at Mains Terminals Class B Limit	12
3.5. EUT Configuration on Test	13
3.6. Operating Condition of EUT	13
3.7. Test Procedure	13
3.8. Conducted Emission at Mains Terminals Test Results	14
4. RADIATED EMISSION MEASUREMENT	19
4.1. Test Equipments	19
4.2. Block Diagram of Test Setup.....	20
4.3. Test Standard	20
4.4. Radiated Emission Class B Limit	21
4.5. EUT Configuration on Test	21
4.6. Operating Condition of EUT	21
4.7. Test Procedure	21
4.8. Radiated Emission Test Results.....	22
5. HARMONIC CURRENT TEST	32
5.1. Test Equipments	32
5.2. Block Diagram of Test Setup.....	32
5.3. Test Standard	32
5.4. Limits of Harmonic Current	32
5.5. EUT Configuration on Test	33
5.6. Operating Condition of EUT	33
5.7. Test Procedure	33
5.8. Test Results.....	33
6. VOLTAGE FLUCTUATIONS & FLICKER TEST	40
6.1. Test Equipment	40
6.2. Block Diagram of Test Setup.....	40
6.3. Test Standard	40
6.4. Limits of Voltage Fluctuation and Flick	40
6.5. EUT Configuration on Test	40
6.6. Operating Condition of EUT	40
6.7. Test Procedure	40
6.8. Test Results.....	40
7. IMMUNITY PERFORMANCE CRITERIA	42
8. ELECTROSTATIC DISCHARGE IMMUNITY TEST	43

8.1. Test Equipments	43
8.2. Block Diagram of Test Setup.....	43
8.3. Test Standard	43
8.4. Severity Levels and Performance Criterion.....	43
8.5. EUT Configuration	43
8.6. Operating Condition of EUT	43
8.7. Test Procedure	44
8.8. Test Results.....	44
8.9. ESD TEST POINT PHOTOS	46
9. RF FIELD STRENGTH SUSCEPTIBILITY TEST.....	48
9.1. Test Equipments	48
9.2. Block Diagram of Test Setup.....	49
9.3. Test Standard	50
9.4. Severity Levels and Performance Criterion.....	50
9.5. EUT Configuration	50
9.6. Operating Condition of EUT	50
9.7. Test Procedure	50
9.8. Test Results.....	50
10. ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST	52
10.1. Test Equipments	52
10.2. Block Diagram of Test Setup.....	52
10.3. Test Standard	52
10.4. Severity Levels and Performance Criterion.....	52
10.5. EUT Configuration	52
10.6. Operating Condition of EUT	52
10.7. Test Procedure	53
10.8. Test Results.....	53
11. SURGE TEST	55
11.1. Test Equipments	55
11.2. Block Diagram of Test Setup.....	55
11.3. Test Standard	55
11.4. Severity Levels and Performance Criterion.....	55
11.5. EUT Configuration	55
11.6. Operating Condition of EUT	55
11.7. Test Procedure	56
11.8. Test Results.....	56
12. CONTINUOUS CONDUCTED DISTURBANCE	58
12.1. Test Equipments	58
12.2. Block Diagram of Test Setup.....	58
12.3. Test Standard	58
12.4. Severity Levels and Performance Criterion.....	59
12.5. EUT Configuration	59
12.6. Operating Condition of EUT	59
12.7. Test Procedure	59
12.8. Test Results.....	59
13. MAGNETIC FIELD IMMUNITY TEST	61
13.1. Test Equipment.....	61
13.2. Block Diagram of Test Setup.....	61
13.3. Test Standard	61
13.4. Severity Levels and Performance Criterion.....	61
13.5. EUT Configuration on Test	61
13.6. Operating Condition of EUT	61
13.7. Test Procedure	61
13.8. Test Results.....	61

14. VOLTAGE DIPS AND INTERRUPTIONS TEST	63
14.1. Test Equipment	63
14.2. Block Diagram of Test Setup.....	63
14.3. Test Standard	63
14.4. Severity Levels and Performance Criterion.....	63
14.5. EUT Configuration	63
14.6. Operating Condition of EUT	63
14.7. Test Procedure	63
14.8. Test Results.....	63
15. PHOTOGRAPHS	65
15.1. Photos of Power Line Conducted Emission Test	65
15.2. Photos of Radiated Emission Test (In 10m Anechoic Chamber)	66
15.3. Photo of Harmonic / Flicker Test	68
15.4. Photos of Electrostatic Discharge Immunity Test	68
15.5. Photo of RF Strength Susceptibility Test	69
15.6. Photo of Electrical Fast Transient/Burst Immunity Test	70
15.7. Photo of Surge Test.....	71
15.8. Photo of Continuous Conducted disturbance Test	71
15.9. Photo of Magnetic Field Test	72
15.10. Photo of Voltage Dips and interruptions test.....	72

TEST REPORT VERIFICATION

Applicant : TPV Electronics (FuJian) Co., Ltd.
Product : LCD Monitor
Model No. : **24G2****(* = 0-9, A-Z, a-z, +, -, \ or blank)
Brand : AOC
Report No. : ACS-E20063
Power Supply : AC 100-240V; 50/60Hz
Test Voltage Standards : AC 230V/50Hz; AC 110V/60Hz; AC 100V/50Hz
EN 55032: 2012+AC: 2013 (Class B)
EN 55032: 2015
EN 55032: 2015+AC: 2016
CISPR 32: 2012
CISPR 32: 2015+COR1: 2016
AS/NZS CISPR 32: 2015
EN 61000-3-2: 2014, EN 61000-3-3: 2013
EN 55035: 2017
(IEC 61000-4-2: 2008, IEC 61000-4-3: 2010,
IEC 61000-4-4: 2012, IEC 61000-4-5: 2014,
IEC 61000-4-6: 2013, IEC 61000-4-8: 2009
IEC 61000-4-11: 2004, IEC 61000-4-11: 2004+A1: 2017)

The device described above is tested by Audix Technology (Shenzhen) Co., Ltd. to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The test results are contained in this test report and Audix Technology (Shenzhen) Co., Ltd. is assumed full responsibility for the accuracy and completeness of test. Also, this report shows that the EUT is technically compliant with requirements of the EN 55032, EN 61000-3-2, EN 61000-3-3 and EN 55035 standards.

This report applies to above tested sample only. This report shall not be reproduced in part without written approval of Audix Technology (Shenzhen) Co., Ltd.

Date of Test : Apr.01 ~ 12, 2020 Report of date: Apr.16, 2020

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